

Search Notes

Application/Control No.

10/519,599

Examiner

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Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2871

SEARCHED

Class	Subclass	Date	Examiner
349	65	3/5/2007	DC
349	58	3/5/2007	DC
362	615	3/5/2007	DC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
same	same	9/4/2007	DC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search report	3/5/2007	DC